

**Search Notes**

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Applicant(s)/Patent under  
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Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
606	169,1	5/16/2007	VWC
604	21-22	5/16/2007	VWC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated search	5/16/2007	VWC